Special Issue

Software Analysis and Testing for Large-Scale Software Systems

Message from the Guest Editors

This Special Issue aims to present the latest research and practices related to improving the dependability and quality of software systems. We solicit high-quality work describing original and unpublished results of theoretical, empirical, conceptual, and experimental research at any point in software quality assurance approaches. Topics of interest include, but are not limited to:

- Reliability, availability, and efficiency of software systems;
- Software testing, verification, and validation;
- Software configuration;
- Program analysis, debugging and comprehension;
- Information and software quality assurance;
- Fault tolerance for software reliability improvement;
- Software vulnerabilities:
- Mining software repositories and software analytics;
- Software maintenance and evolution:
- Benchmarking, tools, industrial applications, and empirical studies:
- Al for software quality assurance;
- Software quality assurance for Al.

Guest Editors

Prof. Dr. Shanshan Li

Dr. Yan Lei

Dr. Zhouyang Jia

Deadline for manuscript submissions

closed (31 December 2023)



Electronics

an Open Access Journal by MDPI

Impact Factor 2.6 CiteScore 6.1



mdpi.com/si/165168

Electronics
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
electronics@mdpi.com

mdpi.com/journal/electronics





Electronics

an Open Access Journal by MDPI

Impact Factor 2.6 CiteScore 6.1



About the Journal

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guestedited by leading experts in selected topics of interest.

Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Author Benefits

High Visibility:

indexed within Scopus, SCIE (Web of Science), CAPlus / SciFinder, Inspec, Ei Compendex and other databases.

Journal Rank:

JCR - Q2 (Engineering, Electrical and Electronic) / CiteScore - Q1 (Electrical and Electronic Engineering)

Rapid Publication:

manuscripts are peer-reviewed and a first decision is provided to authors approximately 16.8 days after submission; acceptance to publication is undertaken in 2.4 days (median values for papers published in this journal in the first half of 2025).

